Handout 11a - Towards distribution-freeness

1 Empirical processes indexed by functions

So far, we have seen that one can perform goodness-of-fit for univariate distributions considering the empirical process

$$v_n(x;F) = \sqrt{n}[F_n(x) - F(x)] \tag{1}$$

which can be seen as a process indexed by intervals of the type $(-\infty, x]$. Whereas, to test multivariate distributions, we rely on the (multivariate) empirical process

$$v_n(\mathbf{x}; F) = \sqrt{n}[F_n(\mathbf{x}) - F(\mathbf{x})], \quad \mathbf{x} = (x_1, \dots, x_p)$$
 (2)

which can be seen as a process indexed by the sets $(-\infty, x_1] \times (-\infty, x_2] \times \dots (-\infty, x_p]$. All of this can be further generalized by considering the empirical processes indexed by functions. For our purposes, we will consider functions $\phi \in \mathcal{L}(F) \subset L^2(F)$. Where $L^2(F)$ is the set of square integrable functions w.r.t. F, i.e.,

$$\emptyset: \int \mathcal{P}_{(k)}^2 dF(k) = \langle \varnothing, \varnothing \rangle_F = E_F \left[\varnothing^2 \right] < + \infty$$

$$\{(k)dk$$

whereas $\mathcal{L}(F)$ is a subset of $L^2(F)$ which collects functions which not only are square integrable w.r.t F but are also orthogonal to 1 or, in other words, have mean zero under F, i.e., Finally,

the empirical process indexed by $\phi \in \mathcal{L}(F)$ is defined as

$$V_{n}(\phi; F) = \int \phi(x) dV_{n}(x; F) \qquad \text{STOCHASTIC INTEGRAL}$$

$$= \int \phi(x) dV_{n} \left[F_{n}(x) - F(x)\right]$$

$$= V_{n} \left[\int \phi(x) dF_{n}(x) - \int \phi(x) dF(x)\right]$$

$$= \frac{1}{V_{n}} \sum_{i=1}^{N} \phi(x; i)$$

$$= \frac{1}{V_{n}} \sum_{i=1}^{N} \phi(x; i)$$

Let's rewrite the multivariate empirical process in equation 2 in this form:

$$V_{n}(\mathcal{O};F) = V_{n}\left[F_{n}(x) - F(x)\right]$$

$$= \frac{1}{V_{n}} \left[\sum_{i=1}^{n} \left[1 \right]_{x \in X} - F(x) \right] = \frac{1}{V_{n}} \left[\sum_{i=1}^{n} \mathcal{O}_{x}(x_{i}) = V_{n}\left(\mathcal{O}_{x_{i}}, F\right)\right]$$

$$= \frac{1}{V_{n}} \left[\sum_{i=1}^{n} \left[1 \right]_{x \in X} - F(x_{i}) \right]$$

$$= \frac{1}{V_{n}} \left[\sum_{i=1}^{n} \mathcal{O}_{x_{i}}(x_{i}) + V_{n}\left(\mathcal{O}_{x_{i}}, F\right)\right]$$

• What are its mean and covariance function?

$$E_{F}\left[\frac{1}{\sqrt{n}}\sum_{i=1}^{n}\varphi_{x}(x_{i})\right] = \sqrt{n} E_{F}\left[\phi_{x}(x_{1})\right] = \sqrt{n} \left(\phi_{x_{1}}(x_{1})\right] = \sqrt{n} \left(\phi_{x_{1}}(x_{1})\right] + \left(\phi_{x_{1}}(x_{1})\right) + \left(\phi_{$$

• What is the limiting distribution of $v_n(\phi_x; F)$?

which is a Gaussian process... and thus it is fully characterized by its mean and covariance $\langle \phi_x, 1 \rangle_F$ and $\langle \phi_x, \phi_{x'} \rangle_F$.

2 Constructing distribution free tests

All the consideration above hold for any arbitrary distribution function. To perform distribution-free goodness-of-fit we will consider a <u>reference distribution Q</u>, and the respective empirical process:

tive empirical process:

$$V_n(\psi_x;Q) = \frac{1}{\sqrt{n}} \mathcal{E}_{i=1}^n \psi_x(x_i) = \frac{1}{\sqrt{n}} \mathcal{E}_{i=1}^n \left[\frac{1}{\sqrt{n}} \mathcal{E}_{i=1}^n \left[$$

But how do we use it? Instead of testing F directly by taking functionals of $v_n(\phi_x; F)$ (see Handout 11), we will construct another empirical process, namely $v_n(kl\psi_x; F)$ (to be defined in a minute) which, under F, has the same limiting distribution of $v_n(\psi_x; Q)$, under Q. Our test statistics will correspond to functionals of $v_n(kl\psi_x; F)$ and, under F, will have the same distribution as functionals of $v_n(\psi_x; Q)$, under Q. This can be done by exploiting the so-called Khmaladze-2 (K-2) transform and which consists of the following steps:

Step 1 - Map ψ_x into $L^2(F)$ via the isometry

$$\mathcal{L}(\mathcal{Q})$$
 $l(t) = \sqrt{rac{q(t)}{f(t)}},$

where q and f are the densities of Q and F, respectively. Obtain $\underline{l\psi_x} \in L^2(F)$. To see that:

$$\langle \ell \psi_{\times}, \ell \psi_{\times} \rangle_{\mathsf{F}} = \int \ell^{2}(k) \psi_{\times}^{2}(k) d \mathsf{F}(k) = \int \frac{q(k)}{g(k)} \psi_{\times}^{2}(k) f(k) dk$$

$$= \int \psi_{\times}^{2}(k) q(k) dk = \int \psi_{\times}^{2}(k) d Q(k) = \langle \psi_{\times}, \psi_{\times} \rangle_{\mathsf{Q}} < +\infty$$

$$\begin{array}{l} \varrho \psi_{x} \in L^{2}(F) \\ Do \ ne \ \varrho \psi_{x} \in \mathcal{R}(F,1)? \\ \langle \varrho \psi_{x}, 1 \rangle_{F} &= \int \varrho(\lambda) \psi_{x}(\lambda) \, dF(\lambda) \\ &= \int \sqrt{\frac{q(\lambda)}{g(\lambda)}} \, \psi_{x}(\lambda) \, f(\lambda) \, d\lambda \\ &= \int \psi_{x}(\lambda) \, \sqrt{\frac{q(\lambda)}{g(\lambda)}} \, d\lambda \neq 0 \\ &= \int \varrho \psi_{x}(\lambda) \, \sqrt{\frac{q(\lambda)}{g(\lambda)}} \, d\lambda \neq 0 \end{array}$$

EL2(F)

Step 2 - Map $l\psi_x$ into $\mathcal{L}(F)$ by means of the the unitary operator

$$K = I - \frac{1 - l}{1 - \langle l, 1 \rangle_F} \langle 1 - l, \cdot \rangle_F,$$
 it preserves (3) the inner product

and obtain $Kl\psi_x \in \mathcal{L}(F)$. To see that:

= < W, 1 % = 0

$$= \ell(k) \psi_{x} (k) - \frac{1 - \ell(k)}{1 - 5\ell(k) \ell + \ell(k)} \int \ell(k) \psi_{x} (k) dk$$

Ø

It follows that $v_n(Kl\psi_x; F)$ and $v_n(\psi_x; Q)$, converge to a Gaussian process $v(\psi_x; Q)$ with mean and covariance:

MEAN
$$\langle k | \psi_x, 1 \rangle_F = \langle \psi_x, 1 \rangle_Q = 0$$

COVARIANCE $\langle k | \psi_x, k | \psi_x \rangle_F = \langle | \psi_x, | \psi_x | \rangle_F = \langle | \psi_x, | \psi_x | \rangle_Q < + \infty$

Hence we construct an entire family of test statistics for testing $H_0: X \sim F$ versus $H_1: X \not\sim F$, i.e.,

- Kolmogorov's statistics: $\sup |v_n(Kl\psi_x; F)| \xrightarrow{d} \sup |v(\psi_x; Q)|$.
- Cramer von Mises statistics: $\int |v_n(Kl\psi_x;F)|^2 dQ(x) \xrightarrow{d} \int |v(\psi_x;Q)|^2 dQ(x)$.
- Anderson-Darling statistics: $\int \left| \frac{v_n(Kl\psi_x;F)}{\sqrt{Q(x)(1-Q(x))}} \right|^2 dQ(x) \xrightarrow{d} \int \left| \frac{v(\psi_x;Q)}{\sqrt{Q(x)(1-Q(x))}} \right|^2 dQ(x)$.

where the convergence is intended as $n \to \infty$, under H_0 . So, for sufficiently large n, a valid testing procedure consists of simulating the distribution of the functionals of $v_n(\psi_x; Q)$ under Q and using it to assign significance to the values of the functionals of $v_n(Kl\psi_x; F)$ observed on the data. For instance, if we decide to use Kolmogorov's statistics, we simulate the distribution of $D_Q = \sup_{\psi_x} |v_n(\psi_x; Q)|$ under Q. This will give us our null distribution. We then evaluate evaluate $D_{obs} = \sup_{\psi_x} |v_n(Kl\psi_x; F)|$ on the data observed. Our p-value is: